

1AP20 Rec'd PCT/PTO 22 MAR 2006

INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>	Docket Number (Optional) <div style="text-align: center; font-weight: bold;">50478-0600</div>		Application Number <div style="text-align: center; font-weight: bold; font-size: 1.2em;">10/573173</div>
	Applicant(s) <div style="text-align: center; font-weight: bold;">Wataru Ikeda et al.</div>		
	Filing Date <div style="text-align: center; font-weight: bold;">Herewith</div>		Group Art Unit <div style="text-align: center; font-weight: bold;">Not yet assigned</div>

U. S. PATENT DOCUMENTS							
EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

U.S. PATENT APPLICATION PUBLICATIONS							
EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		2002/0021887	2.21.2002	Yoshikawa			
		2003/0161615	8.28.2003	Tsumagari et al.			
		2002/0194618	12.19.2002	Okada et al.			

FOREIGN PATENT DOCUMENTS								
EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
		2002-369154	12.20.2002	Japan (See US 2002/0194618 Family Patent Application)				
		2003-249057	9.5.2003	Japan (See US 2003/0161615 Family Patent Application)				
		06-004166	1.14.1994	Japan w/English Abstract			X	
		06-230946	8.19.1994	Japan w/English Abstract			X	
		2001-238161	8.31.2001	Japan w/English Abstract			X	
		2002-57990	2.22.2002	Japan (See US 2002/0021887 Family Patent Application)			X	
		10-063362	3.6.1998	Japan w/English Abstract			X	
		2004-206863	7.22.2004	Japan w/English Abstract			X	

OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>		

EXAMINER	DATE CONSIDERED
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	